


<b>Search Notes</b>  	<b>Application/Control No.</b>  10004959	<b>Applicant(s)/Patent Under Reexamination</b>  MCLAIN ET AL.
	<b>Examiner</b>  Pan, Yuwen	<b>Art Unit</b>  2618

SEARCHED			
Class	Subclass	Date	Examiner
455	13.4, 522, 427	2/19/08	YP

SEARCH NOTES		
Search Notes	Date	Examiner
EAST text search	2/19/08	YP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
455	13.4	6/20/08	YP